

TC74HC597AP, TC74HC597AF

8-Bit Latch/Shift Register

The TC74HC597A is a high speed CMOS 8-BIT PARALLEL-IN/SERIAL-IN SERIAL-OUT LATCH/SHIFT REGISTER fabricated with silicon gate C²MOS technology.

It achieves the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation.

It consists of an 8-bit data register feeding an 8-bit shift register. The parallel data on the A to H inputs is stored in the input register on the positive going transition of RCK.

When the $\overline{\text{SLOAD}}$ input is held low, the input register data is passed into the shift registers. When $\overline{\text{SLOAD}}$ input is held high, the serial data input (SI) is enabled and the eight flip-flops perform serial shifting on the positive transition of SCK.

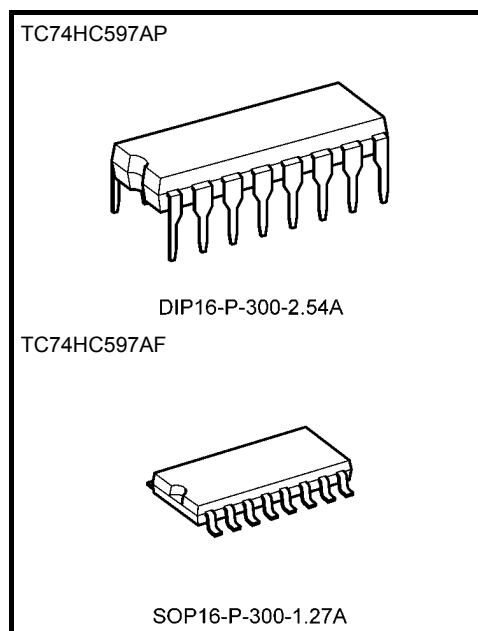
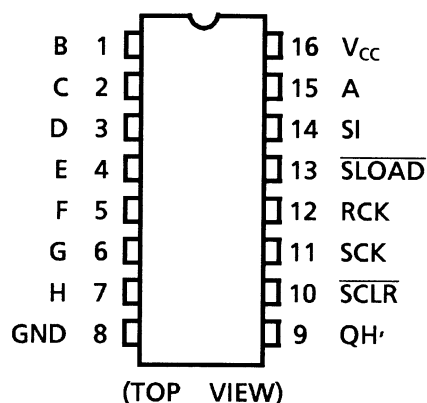
A direct clear input ($\overline{\text{SCLR}}$) sets the 8-bit shift register to zero.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

Features

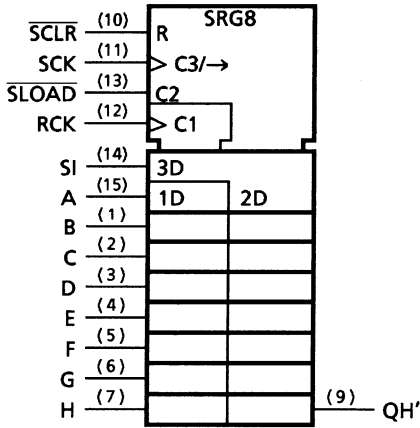
- High speed: $f_{\text{max}} = 60 \text{ MHz}$ (typ.) at $V_{\text{CC}} = 5 \text{ V}$
- Low power dissipation: $I_{\text{CC}} = 4 \mu\text{A}$ (max) at $T_a = 25^\circ\text{C}$
- High noise immunity: $V_{\text{NIH}} = V_{\text{NIL}} = 28\% V_{\text{CC}}$
- Output drive capability: 10 LSTTL loads
- Symmetrical output impedance: $|I_{\text{OH}}| = I_{\text{OL}} = 4 \text{ mA}$ (min)
- Balanced propagation delays: $t_{\text{pLH}} \approx t_{\text{pHL}}$
- Wide operating voltage range: $V_{\text{CC}} (\text{opr}) = 2 \text{ to } 6 \text{ V}$
- Pin and function compatible with 74LS597

Pin Assignment








| | |
|-------------------|-----------------|
| Weight | |
| DIP16-P-300-2.54A | : 1.00 g (typ.) |
| SOP16-P-300-1.27A | : 0.18 g (typ.) |

IEC Logic Symbol

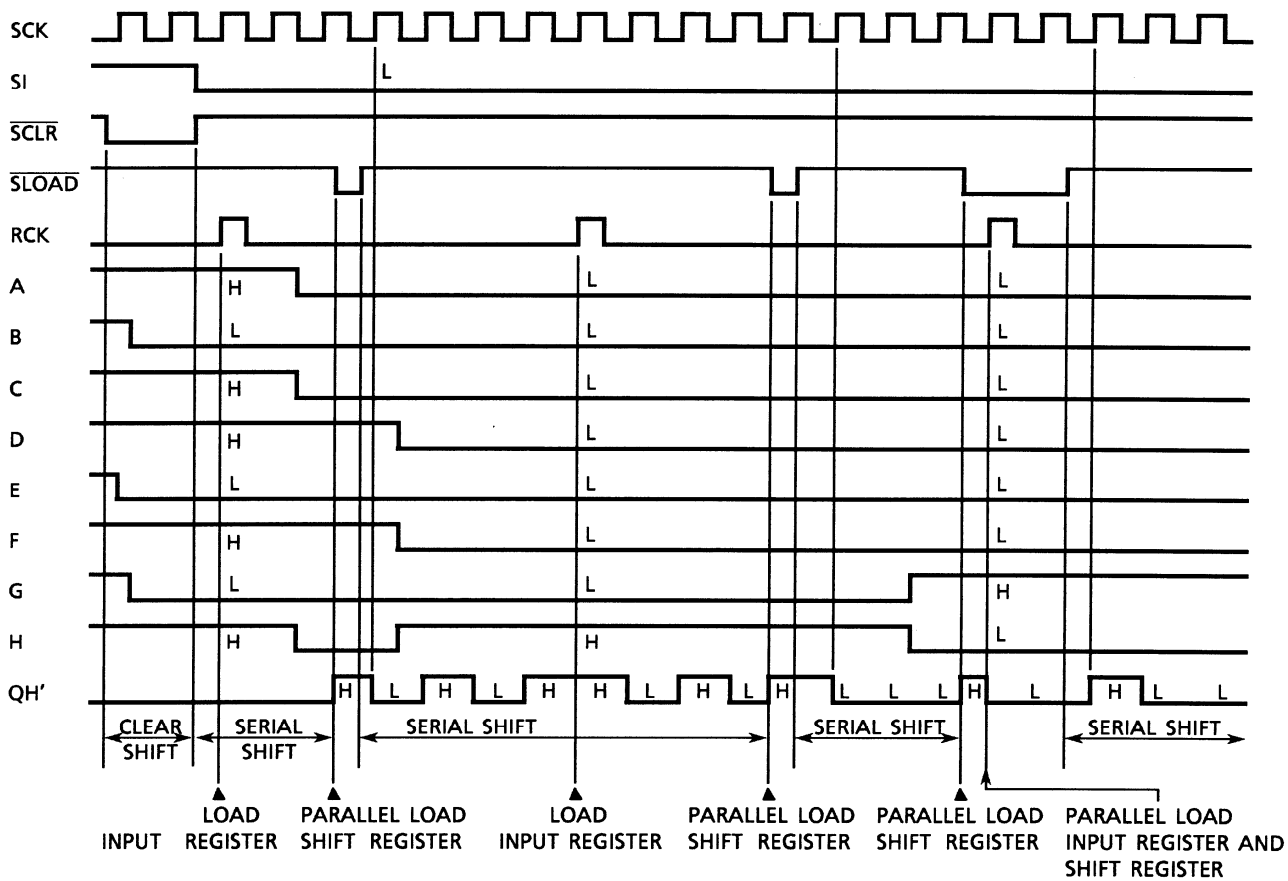


Truth Table

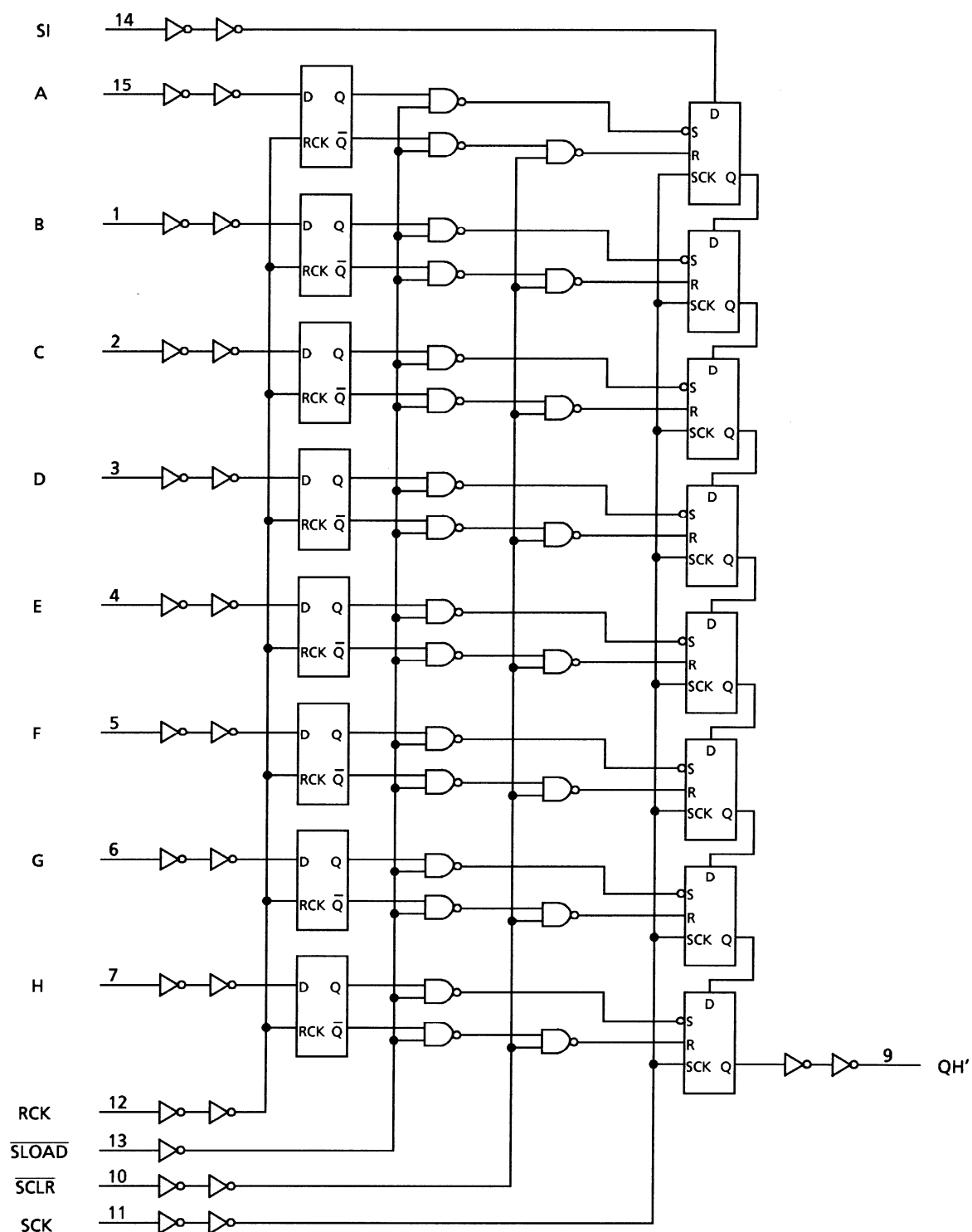
| Inputs | | | | | Function |
|--------|---|------|-------|---|--|
| SI | SCK | SCLR | SLOAD | RCK | |
| X | X | L | H | X | S.R. is cleared to "L" |
| X | X | H | L | X | Input register data is stored into S.R. |
| L |  | H | H | X | First stage of S.R. become "L". Other stages store the data of previous stage, respectively. |
| H |  | H | H | X | First stage of S.R. become "H". Other stages store the data of previous stage, respectively. |
| X |  | H | H | X | State of S.R. is not changed. |
| X | X | X | X |  | Input data on A to H line is stored into input register. |
| X | X | X | X |  | Storage register stage is not changed. |

X: Don't care

Timing Chart



System Diagram



Absolute Maximum Ratings (Note 1)

| Characteristics | Symbol | Rating | Unit |
|-----------------------------|-----------|------------------------------|------|
| Supply voltage range | V_{CC} | -0.5 to 7.0 | V |
| DC input voltage | V_{IN} | -0.5 to $V_{CC} + 0.5$ | V |
| DC output voltage | V_{OUT} | -0.5 to $V_{CC} + 0.5$ | V |
| Input diode current | I_{IK} | ± 20 | mA |
| Output diode current | I_{OK} | ± 20 | mA |
| DC output current | I_{OUT} | ± 25 | mA |
| DC V_{CC} /ground current | I_{CC} | ± 50 | mA |
| Power dissipation | P_D | 500 (DIP) (Note 2)/180 (SOP) | mW |
| Storage temperature | T_{stg} | -65 to 150 | °C |

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

Note 2: 500 mW in the range of $T_a = -40$ to 65°C . From $T_a = 65$ to 85°C a derating factor of $-10\text{ mW}/^\circ\text{C}$ should be applied until 300 mW.

Operating Ranges (Note)

| Characteristics | Symbol | Rating | Unit |
|--------------------------|------------|---|------|
| Supply voltage | V_{CC} | 2 to 6 | V |
| Input voltage | V_{IN} | 0 to V_{CC} | V |
| Output voltage | V_{OUT} | 0 to V_{CC} | V |
| Operating temperature | T_{opr} | -40 to 85 | °C |
| Input rise and fall time | t_r, t_f | 0 to 1000 ($V_{CC} = 2.0\text{ V}$) 0 to 500 ($V_{CC} = 4.5\text{ V}$) 0 to 400 ($V_{CC} = 6.0\text{ V}$) | ns |

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either VCC or GND.

Electrical Characteristics
DC Characteristics

| Characteristics | Symbol | Test Condition | | Ta = 25°C | | | Ta = -40 to 85°C | | Unit |
|---------------------------|-----------------|--|---------------------------|------------------------|----------------------|-------------------|----------------------|----------------------|------|
| | | | | V _{CC} (V) | Min | Typ. | Max | Min | Max |
| High-level input voltage | V _{IH} | — | | 2.0 4.5 6.0 | 1.50 3.15 4.20 | — — — | — — — | 1.50 3.15 4.20 | V |
| Low-level input voltage | V _{IL} | — | | 2.0 4.5 6.0 | — — — | — — — | 0.50 1.35 1.80 | — — — | V |
| High-level output voltage | V _{OH} | V _{IN} = V _{IH} or V _{IL} | I _{OH} = -20 µA | 2.0 4.5 6.0 | 1.9 4.4 5.9 | 2.0 4.5 6.0 | — — — | 1.9 4.4 5.9 | V |
| | | | I _{OH} = -4 mA | 4.5 6.0 | 4.18 5.68 | 4.31 5.80 | — — | 4.13 5.63 | |
| | | | I _{OH} = -5.2 mA | 4.5 6.0 | 4.18 5.68 | 4.31 5.80 | — — | 4.13 5.63 | |
| | | | I _{OH} = -5.2 mA | 4.5 6.0 | 4.18 5.68 | 4.31 5.80 | — — | 4.13 5.63 | |
| Low-level output voltage | V _{OL} | V _{IN} = V _{IH} or V _{IL} | I _{OL} = 20 µA | 2.0 4.5 6.0 | — — — | 0.0 0.0 0.0 | 0.1 0.1 0.1 | — — — | V |
| | | | I _{OL} = 4 mA | 4.5 6.0 | — — | 0.17 0.18 | 0.26 0.26 | — — | |
| | | | I _{OL} = 5.2 mA | 4.5 6.0 | — — | 0.17 0.18 | 0.26 0.26 | — — | |
| | | | I _{OL} = 5.2 mA | 4.5 6.0 | — — | 0.17 0.18 | 0.26 0.26 | — — | |
| Input leakage current | I _{IN} | V _{IN} = V _{CC} or GND | | 6.0 | — | — | ±0.1 | — | µA |
| Quiescent supply current | I _{CC} | V _{IN} = V _{CC} or GND | | 6.0 | — | — | 4.0 | — | µA |

Timing Requirements (input: $t_r = t_f = 6 \text{ ns}$)

| Characteristics | Symbol | Test Condition | Ta = 25°C | | Ta = -40 to 85°C | Unit |
|--|------------------------|----------------|---------------------|------|------------------------|------|
| | | | V _{CC} (V) | Typ. | Limit | |
| Minimum pulse width (SCK, RCK) | t_W (H) t_W (L) | — | 2.0 | — | 75 | ns |
| | | | 4.5 | — | 15 | |
| | | | 6.0 | — | 13 | |
| Minimum pulse width ($\overline{\text{SCLR}}$) | t_W (L) | — | 2.0 | — | 75 | ns |
| | | | 4.5 | — | 15 | |
| | | | 6.0 | — | 13 | |
| Minimum pulse width ($\overline{\text{SLOAD}}$) | t_W (L) | — | 2.0 | — | 75 | ns |
| | | | 4.5 | — | 15 | |
| | | | 6.0 | — | 13 | |
| Minimum set-up time (RCK- $\overline{\text{SLOAD}}$) | t_s | — | 2.0 | — | 100 | ns |
| | | | 4.5 | — | 20 | |
| | | | 6.0 | — | 17 | |
| Minimum set-up time (SI-SCK) | t_s | — | 2.0 | — | 75 | ns |
| | | | 4.5 | — | 15 | |
| | | | 6.0 | — | 13 | |
| Minimum set-up time (PI-RCK) | t_s | — | 2.0 | — | 75 | ns |
| | | | 4.5 | — | 15 | |
| | | | 6.0 | — | 13 | |
| Minimum hold time | t_h | — | 2.0 | — | 0 | ns |
| | | | 4.5 | — | 0 | |
| | | | 6.0 | — | 0 | |
| Minimum removal time ($\overline{\text{SCLR}}$, $\overline{\text{SLOAD}}$) | t_{rem} | — | 2.0 | — | 75 | ns |
| | | | 4.5 | — | 15 | |
| | | | 6.0 | — | 13 | |
| Clock frequency | f | — | 2.0 | — | 6 | MHz |
| | | | 4.5 | — | 30 | |
| | | | 6.0 | — | 35 | |

AC Characteristics ($C_L = 15 \text{ pF}$, $V_{CC} = 5 \text{ V}$, $T_a = 25^\circ\text{C}$, input: $t_r = t_f = 6 \text{ ns}$)

| Characteristics | Symbol | Test Condition | Min | Typ. | Max | Unit |
|---|--------------------------------------|--|-----|------|-----|------|
| Output transition time | t_{TLH} | — | — | 5 | 8 | ns |
| | t_{THL} | | | | | |
| Propagation delay time (SCK-QH') | t_{PLH} | — | — | 16 | 25 | ns |
| | t_{PHL} | | | | | |
| Propagation delay time ($\overline{\text{SCLR}}$ -QH') | t_{PHL} | — | — | 20 | 32 | ns |
| Propagation delay time ($\overline{\text{SLOAD}}$ -QH') | t_{PLH} | — | — | 18 | 30 | ns |
| | t_{PHL} | | | | | |
| Propagation delay time (RCK-QH') | t_{PLH} t_{PHL} | $\overline{\text{SLOAD}} = \text{"L"}$ | — | 25 | 37 | ns |
| Clock frequency | f_{max} | — | 30 | 59 | — | MHz |

AC Characteristics ($C_L = 50 \text{ pF}$, input: $t_r = t_f = 6 \text{ ns}$)

| Characteristics | Symbol | Test Condition | V_{CC} (V) | $T_a = 25^\circ\text{C}$ | | | $T_a = -40 \text{ to } 85^\circ\text{C}$ | | Unit |
|---|------------------------|---------------------------------|-----------------|--------------------------|------|-----|--|-----|------|
| | | | | Min | Typ. | Max | Min | Max | |
| Output transition time | t_{TLH} t_{THL} | — | 2.0 | — | 32 | 75 | — | 95 | ns |
| | | | 4.5 | — | 8 | 15 | — | 19 | |
| | | | 6.0 | — | 7 | 13 | — | 16 | |
| Propagation delay time (SCK-QH') | t_{pLH} t_{pHL} | — | 2.0 | — | 78 | 145 | — | 180 | ns |
| | | | 4.5 | — | 20 | 29 | — | 36 | |
| | | | 6.0 | — | 16 | 25 | — | 31 | |
| Propagation delay time ($\overline{\text{SCLR}}$ -QH') | t_{pHL} | — | 2.0 | — | 90 | 175 | — | 220 | ns |
| | | | 4.5 | — | 24 | 35 | — | 44 | |
| | | | 6.0 | — | 20 | 30 | — | 37 | |
| Propagation delay time ($\overline{\text{SLOAD}}$ -QH') | t_{pLH} t_{pHL} | — | 2.0 | — | 80 | 175 | — | 220 | ns |
| | | | 4.5 | — | 22 | 35 | — | 44 | |
| | | | 6.0 | — | 18 | 30 | — | 37 | |
| Propagation delay time (RCK-QH') | t_{pLH} t_{pHL} | $\overline{\text{SLOAD}} = "L"$ | 2.0 | — | 112 | 210 | — | 265 | ns |
| | | | 4.5 | — | 30 | 42 | — | 53 | |
| | | | 6.0 | — | 24 | 36 | — | 45 | |
| Maximum clock frequency | f_{\max} | — | 2.0 | 6 | 12 | — | 5 | — | MHz |
| | | | 4.5 | 30 | 48 | — | 24 | — | |
| | | | 6.0 | 35 | 50 | — | 28 | — | |
| Input capacitance | C_{IN} | — | — | — | 5 | 10 | — | 10 | pF |
| Power dissipation capacitance | C_{PD} (Note) | — | — | — | 60 | — | — | — | pF |

Note: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

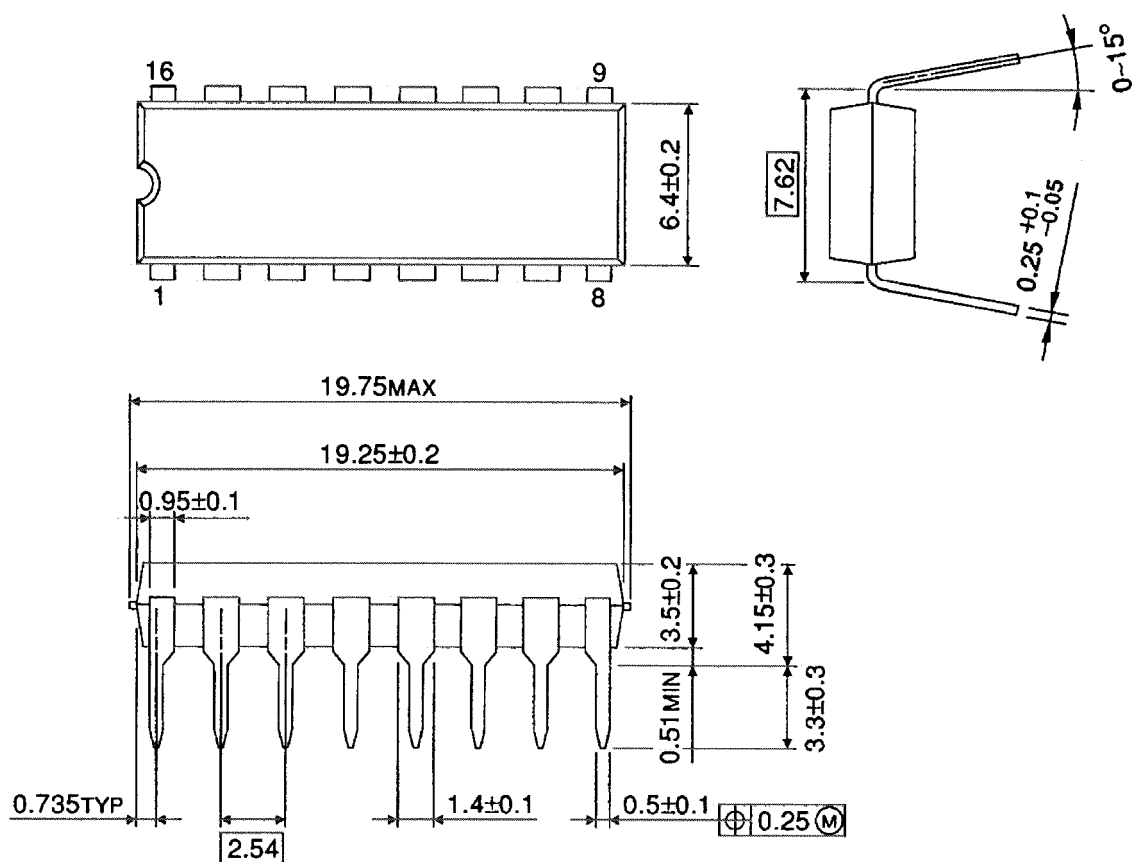
Average operating current can be obtained by the equation:

$$I_{CC}(\text{opr}) = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$$

Package Dimensions

DIP16-P-300-2.54A

Unit : mm

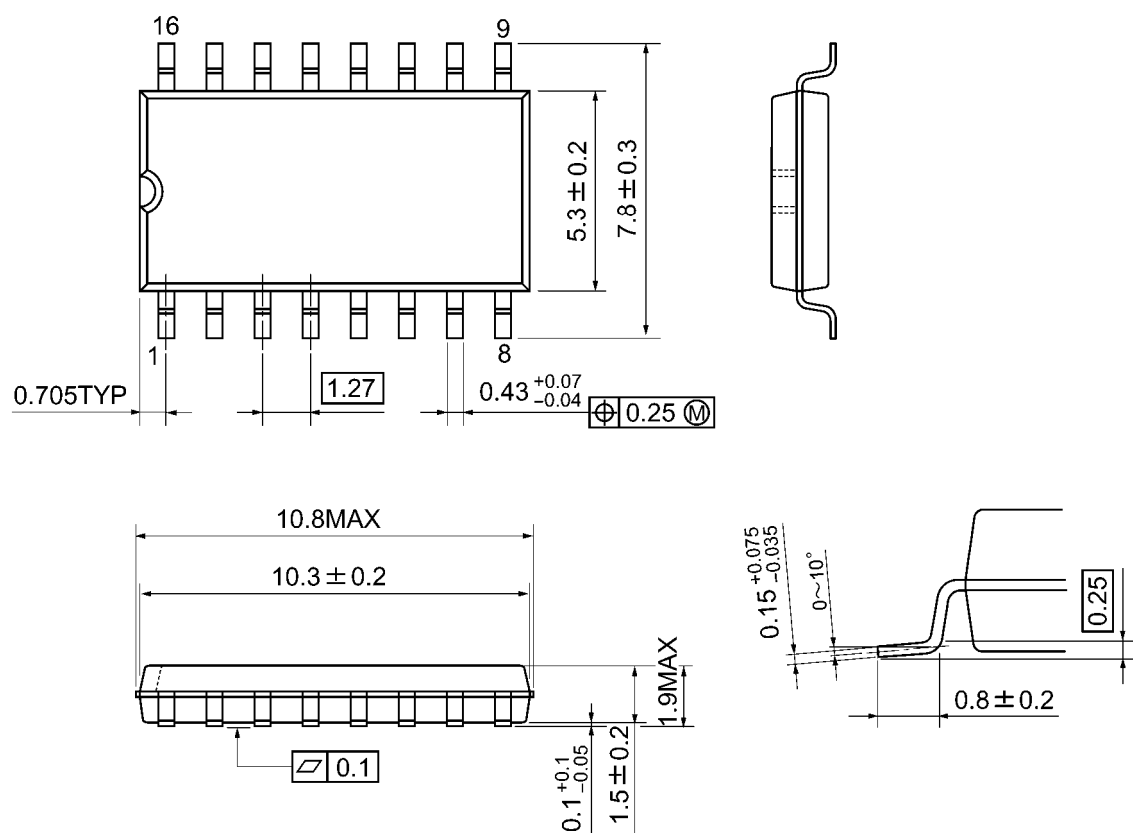


Weight: 1.00 g (typ.)

Package Dimensions

SOP16-P-300-1.27A

Unit: mm



Weight: 0.18 g (typ.)

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